Bolchini, Cristiana (ed.); Kundu, Sandip (ed.); Pontarelli, Salvatore (ed.)
Guest editorial: IEEE Transactions on Computers and IEEE Transactions on Nanotechnology: Joint special section on defect and fault tolerance in VLSI and nanotechnology systems.
(English) [Zbl 1360.00097]

Editorial remark: No review copy delivered.

MSC:
00B15 Collections of articles of miscellaneous specific interest
68-06 Proceedings, conferences, collections, etc. pertaining to computer science
68M07 Mathematical problems of computer architecture
68M15 Reliability, testing and fault tolerance of networks and computer systems
68W35 Hardware implementations of nonnumerical algorithms (VLSI algorithms, etc.)

Full Text: DOI